



ALPHA & OMEGA
SEMICONDUCTOR



AOD464

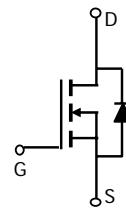
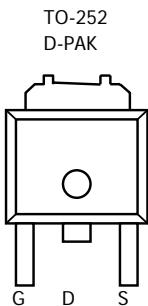
N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOD464 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in high voltage synchronous rectification, load switching and general purpose applications. Standard Product AOD464 is Pb-free (meets ROHS & Sony 259 specifications). AOD464L is a Green Product ordering option. AOD464 and AOD464L are electrically identical.

Features

$V_{DS} (V) = 105V$
 $I_D = 40 A \quad (V_{GS} = 10V)$
 $R_{DS(ON)} < 28 m\Omega \quad (V_{GS} = 10V) @ 20A$
 $R_{DS(ON)} < 31 m\Omega \quad (V_{GS} = 6V)$



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	105	V
Gate-Source Voltage	V_{GS}	± 25	V
Continuous Drain Current ^A	I_D	40	A
$T_C=100^\circ C$		28	
Pulsed Drain Current ^C	I_{DM}	80	
Avalanche Current ^C	I_{AR}	20	A
Repetitive avalanche energy $L=0.1mH$ ^C	E_{AR}	200	mJ
Power Dissipation ^B	P_D	100	W
$T_C=100^\circ C$		50	
Power Dissipation ^A	P_{DSM}	2.3	W
$T_A=70^\circ C$		1.5	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$t \leq 10s$	$R_{\theta JA}$	15	°C/W
Maximum Junction-to-Ambient ^A	Steady-State	$R_{\theta JA}$	45	°C/W
Maximum Junction-to-Case ^B	Steady-State	$R_{\theta JC}$	1	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=10\text{mA}, V_{GS}=0\text{V}$	105			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=84\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		1		μA
				5		
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 25\text{V}$			100	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.5	3.2	4	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	80			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$		21.5	28	$\text{m}\Omega$
		$T_J=125^\circ\text{C}$		32	40	
		$V_{GS}=6\text{V}, I_D=20\text{A}$		24	31	
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		50		S
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.73	1	V
I_S	Maximum Body-Diode Continuous Current				55	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$		2038	2445	pF
C_{oss}	Output Capacitance			204		pF
C_{rss}	Reverse Transfer Capacitance			85		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		1.3	1.56	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=20\text{A}$		38.5	46	nC
Q_{gs}	Gate Source Charge			8		nC
Q_{gd}	Gate Drain Charge			10		nC
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, R_L=2.7\Omega, R_{\text{GEN}}=3\Omega$		12.7		ns
t_r	Turn-On Rise Time			8.2		ns
$t_{\text{D(off)}}$	Turn-Off Delay Time			31.5		ns
t_f	Turn-Off Fall Time			11.2		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=20\text{A}, dI/dt=100\text{A}/\mu\text{s}$		59.6	74	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, dI/dt=100\text{A}/\mu\text{s}$		161		nC

A: The value of R_{fJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on R_{fJA} and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$.

D. The R_{fJA} is the sum of the thermal impedance from junction to case R_{fJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$.

G. The maximum current rating is limited by bond-wires.

H. These tests are performed with the device mounted on 1 in. 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

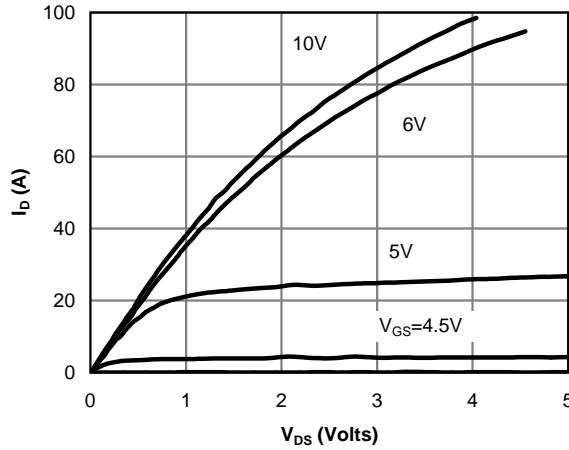


Fig 1: On-Region Characteristics

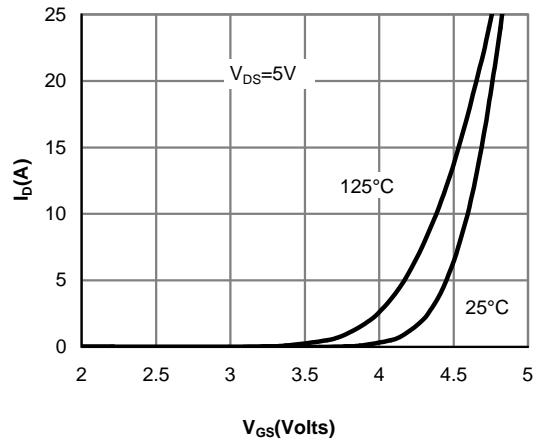


Figure 2: Transfer Characteristics

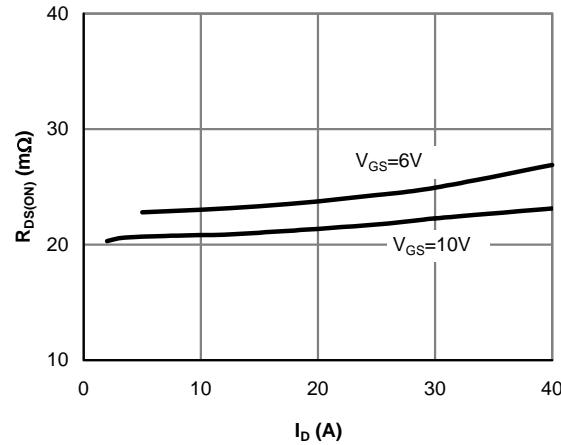


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

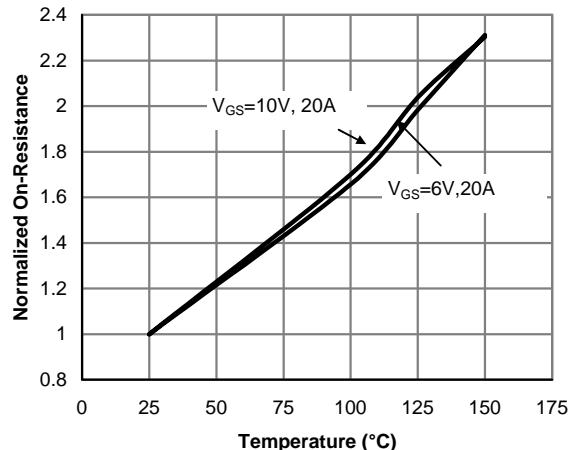


Figure 4: On-Resistance vs. Junction Temperature

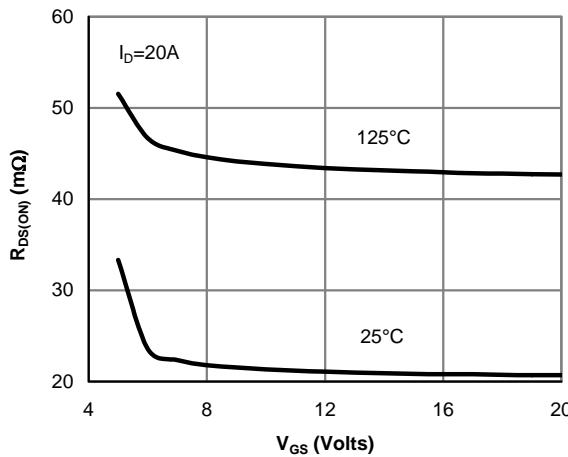


Figure 5: On-Resistance vs. Gate-Source Voltage

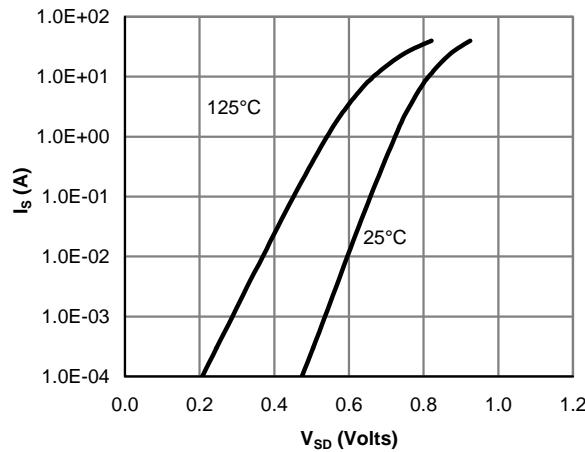
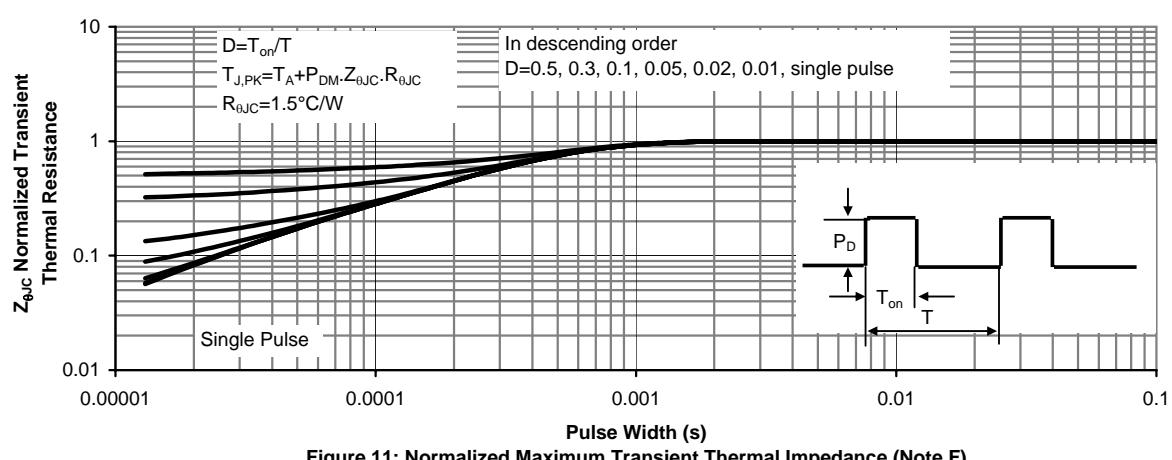
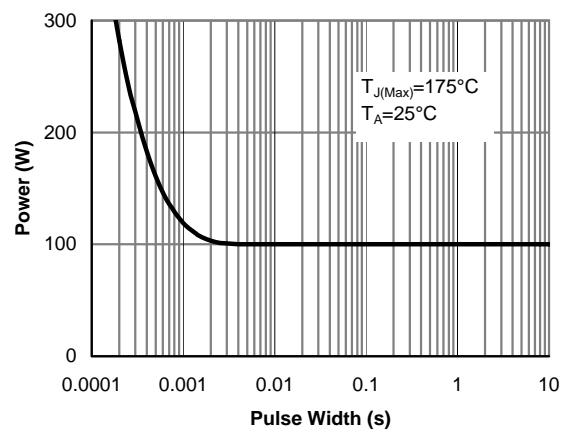
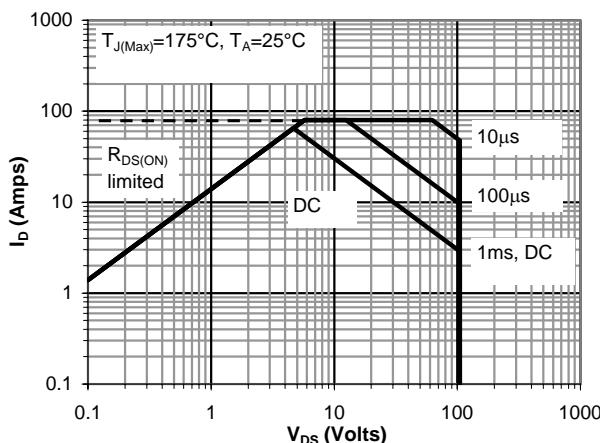
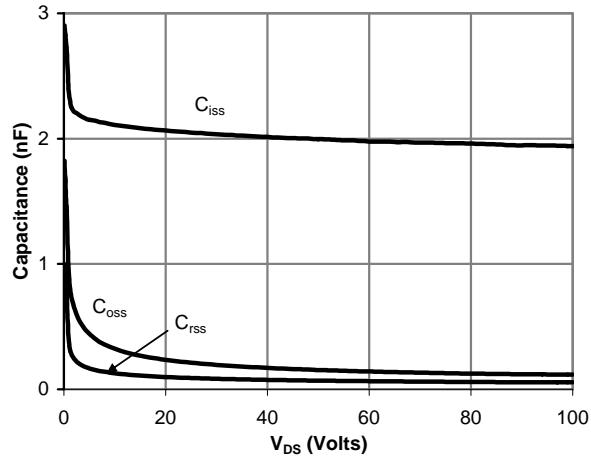
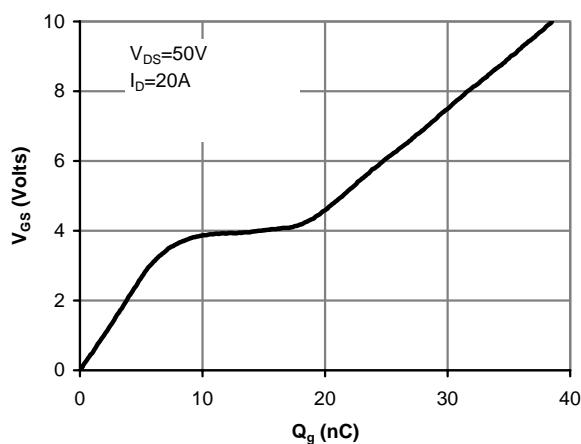


Figure 6: Body-Diode Characteristics

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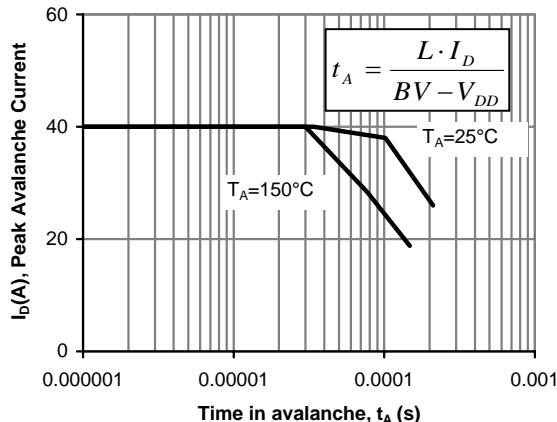


Figure 12: Single Pulse Avalanche capability

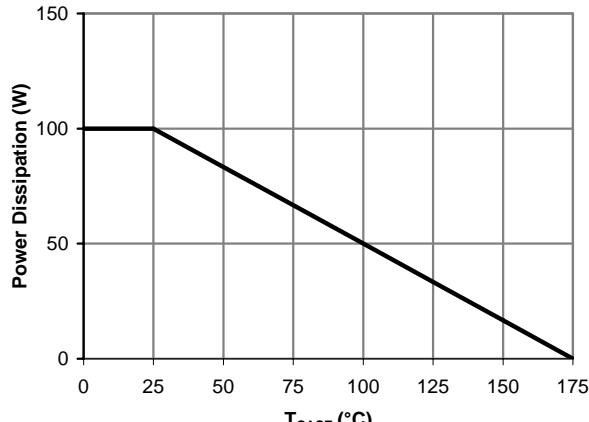


Figure 13: Power De-rating (Note B)

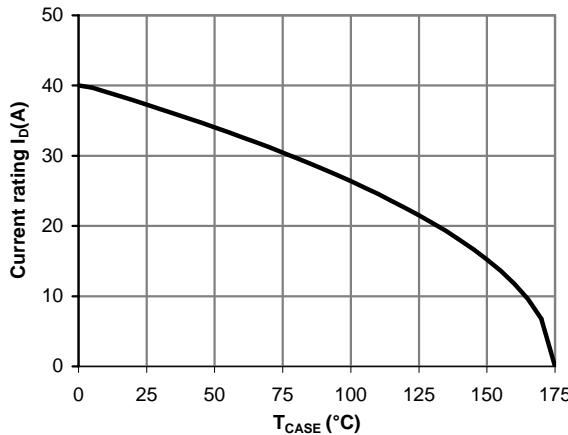


Figure 14: Current De-rating (Note B)

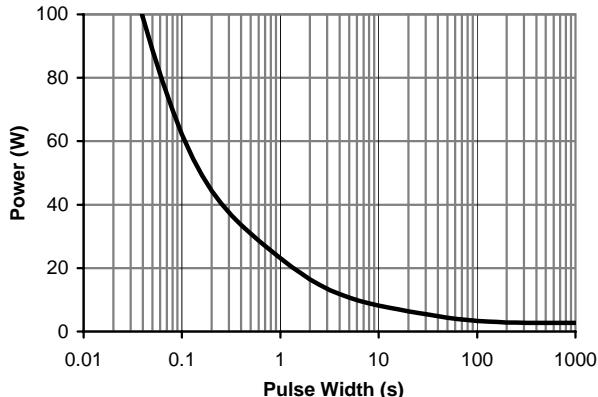


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

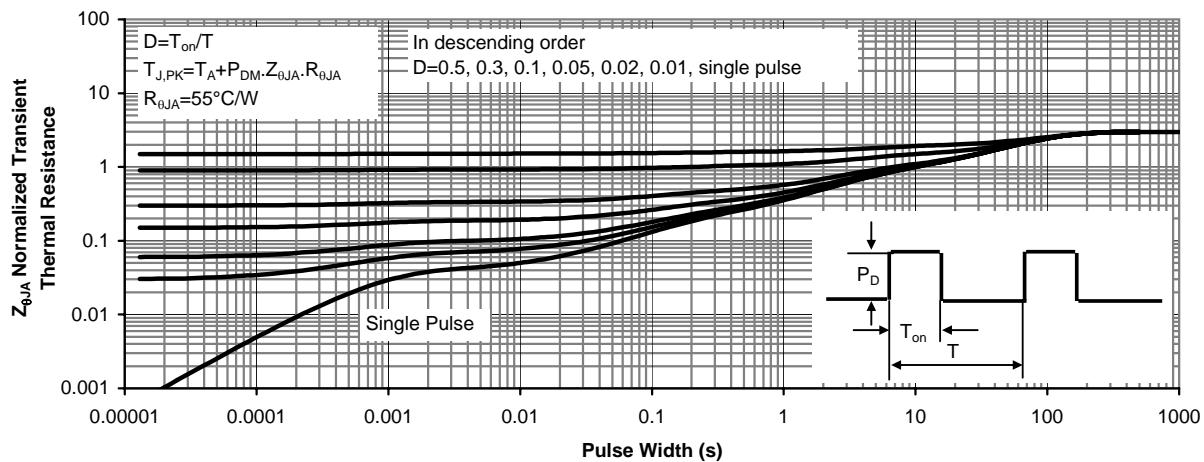


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)